

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	0	("50264177").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 13:57
S3	1	("6,538,374").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/09/28 17:35
S4	1	("20050264177").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/09/30 19:32
S5	10	"1367647"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 13:57
S6	5	"2004070808"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:41
S7	2	"20040070808"	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 13:59
S8	0	("2005/0264177").URPN.	USPAT	OR	ON	2006/12/07 15:35
S9	16754	((313/495-512) or (315/169.3) or (257/40,79) or (428/690)).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 15:37
S10	4194	(313/506,509).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 15:38
S11	1421115	(electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:08
S13	12128146	(hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:48

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S16	3742157	(dielectric glass insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) "SiOC.")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:26
S17	561120	(photo\$3resist\$3 photo\$3etch\$3 photolithography photo\$sensitive)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:47
S18	7142206	(electrode wire metal anode cathode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:49
S19	1421115	(electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:49
S20	12128146	(hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:49
S21	3742157	(dielectric glass insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) "SiOC.")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:57
S22	42075	S19 and S20 with S21 with S18	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:57
S23	1598	S22	DERWENT	OR	ON	2006/12/07 15:56
S24	2345478	(dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) "SiOC.")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:09

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S25	34108	S19 and S20 with S24 with S18	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:57
S26	16754	((313/495-512) or (315/169.3) or (257/40,79) or (428/690)).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 15:57
S27	4538	S22 and S26	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 15:58
S28	4194	(313/506,509).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 15:58
S29	1441	S22 and S28	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:01
S30	3742157	(dielectric glass insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) "SiOC.")	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:02
S31	561120	(photo\$3resist\$3 photo\$3etch\$3 photolithography photo\$sensitive)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:02
S32	89502	S31 with S30	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:05
S33	4	((("7102281") or ("6903513") or ("7081716") or ("7091669")).PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 16:05

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S34	7142206	(electrode wire metal anode cathode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:05
S35	1421115	(electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:05
S36	12128146	(hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:05
S37	34110	(electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive))) and (hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated) with (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:30
S38	1213	S37	DERWENT	OR	ON	2006/12/07 16:11
S39	16754	((313/495-512) or (315/169.3) or (257/40,79) or (428/690)).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 16:11
S40	3556	S37 and S39	US-PGPUB; USPAT; USOCR	OR	ON	2006/12/07 16:12
S41	4194	(313/506,509).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 16:25
S42	966	S37 and S41	US-PGPUB; USPAT; USOCR	OR	ON	2006/12/07 16:12
S43	0	("2004/0070808").URPN.	USPAT	OR	ON	2006/12/07 16:14
S44	1	("6856087").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 16:24

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S45	2270	S41 and (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:27
S46	969	S41 and (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode) with (hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:06
S47	966	S42 and S46	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:29
S48	0	S42 not S46	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:29
S49	3	S46 not S42	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:29
S50	12578	((dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode) with (hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)).ti.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/08 11:12

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S51	206	((electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive))) and (hole through\$3hole window notch opening via aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated) with (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode)).ti.	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:34
S52	346	S50 and S37	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 16:31
S53	969	S46 not S51	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:02
S54	933	S41 and (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (electrode wire metal anode cathode) with (hole through\$3hole window notch opening aperture slot slit gap passage passageway rift breach fissure crack\$3 separation separated)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:12
S56	561120	(photo\$3resist\$3 photo\$3etch\$3 photolithography photo\$sensitive)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:12
S57	462	S54 and S56	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:24
S58	1	("20030111957").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 17:24

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S59	48343	(dummy inactive) and (electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:48
S60	152	S59 and S41	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:47
S61	2452	(dummy inactive) with (electro\$3lumines\$6 EL OLED OELD lumines\$6 phosphor photo\$3luminescen\$3 light\$emitting light\$emission light\$emissive ((light photo photon) near3 (emitting emission emissive)))	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:49
S62	61	S61 and S41	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/07 17:53
S63	1	("20030156079").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/07 17:53
S64	18	(US-20050264177-\$ or US-20040070808-\$ or US-20060182996-\$ or US-20030111957-\$).did. or (US-4757235-\$ or US-7142770-\$ or US-7091666-\$ or US-7053548-\$). did. or (US-20060097263-\$ or JP-2006085916-\$ or WO-2005067352-\$ or US-20050046341-\$ or US-20040263072-\$ or WO-2004107821-\$ or JP-2004192813-\$ or JP-2003142278-\$ or WO-2003007377-\$ or EP-1195814-\$).did.	US-PGPUB; USPAT; DERWENT	OR	ON	2006/12/08 11:07
S65	6	S64 and (groove indentation channel depression notch slit trench)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/08 11:09

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S66	4194	(313/506,509).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/08 11:13
S67	37	S66 and (dielectric insulat\$3 benzocyclobutene BCB (silicon near oxycarbide) SiOC) with (groove trench)	US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2006/12/08 11:13
S68	1	("6429584").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/08 14:13
S69	12	("5962970" "6099746" "6137220").PN. OR ("6429584"). URPN.	US-PGPUB; USPAT; USOCR	OR	ON	2006/12/08 14:18
S70	1466	(313/582).CCLS.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/11 13:18
S71	1	("20060266660").PN.	US-PGPUB; USPAT; USOCR	OR	OFF	2006/12/12 16:17